

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10660750	JOO ET AL.
	Examiner	Art Unit
	Carter, Aaron W	2624

SEARCHED

Class	Subclass	Date	Examiner
382	115-127	12/22/06	AWC
340	5.1,5.2,5.52,5.53	12/22/06	AWC
356	71	12/22/06	AWC
713	186	12/22/06	AWC
902	3	12/22/06	AWC
Updated Above		3/22/07	AWC
Updated Above		6/7/07	AWC
Updated Above		12/10/07	AWC

SEARCH NOTES

Search Notes	Date	Examiner
EAST Text Search (USPAT, PGPUB) See Search History Printout	12/22/06	AWC
Inventor Name Search (See PALM Search History Printout, Check Marks Indicate Applications Considered)	12/22/06	AWC
Updated EAST Text Search (USPAT, PGPUB) See Search History Printout	12/10/07	AWC
Consulted Wenpeng Chen	12/6/07	AWC
Interference Search History Printout	12/10/07	AWC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
PGPUB Text Search		12/10/07	AWC